

Silicon Carbide (SiC) MOSFET - EliteSiC, 23 mohm, 650 V, M3S, D2PAK-7L

NTBG023N065M3S

Features

- Typical $R_{DS(ON)} = 23 \text{ m}\Omega$ @ $V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge ($Q_{G(tot)} = 69 \text{ nC}$)
- High Speed Switching with Low Capacitance ($C_{oss} = 153 \text{ pF}$)
- 100% Avalanche Tested
- This Device is Halide Free and RoHS Compliant with Exemption 7a, Pb-Free 2LI (on Second Level Interconnection)

Applications

- SMPS, Solar Inverters, UPS, Energy Storages, EV Charging Infrastructure

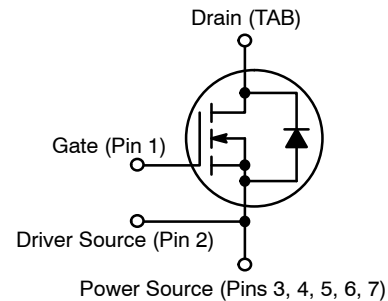
MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	650	V
Gate-to-Source Voltage	V_{GS}	-8/+22	
Continuous Drain Current	$T_C = 25^\circ\text{C}$	I_D	70
Power Dissipation		P_D	263
Continuous Drain Current	$T_C = 100^\circ\text{C}$	I_D	50
Power Dissipation		P_D	131
Pulsed Drain Current (Note 1)	$T_C = 25^\circ\text{C}$, $t_p = 100 \mu\text{s}$	I_{DM}	216
Continuous Source-Drain Current (Body Diode)	$T_C = 25^\circ\text{C}$, $V_{GS} = -3 \text{ V}$	I_S	38
	$T_C = 100^\circ\text{C}$, $V_{GS} = -3 \text{ V}$		23
Pulsed Source-Drain Current (Body Diode) (Note 1)	$T_C = 25^\circ\text{C}$, $V_{GS} = -3 \text{ V}$, $t_p = 100 \mu\text{s}$	I_{SM}	175
Single Pulse Avalanche Energy (Note 2)	$I_{LPK} = 19.6 \text{ A}$, $L = 1 \text{ mH}$	E_{AS}	192
Operating Junction and Storage Temperature	T_J, T_{stg}	-55 to 175	$^\circ\text{C}$
Lead Temperature for Soldering Purposes (1/8" from Case for 10 s)	T_L	270	

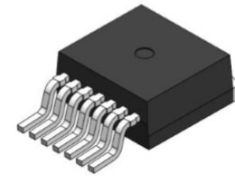
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Single pulse, limited by max junction temperature.
2. E_{AS} of 192 mJ is based on starting $T_J = 25^\circ\text{C}$, $L = 1 \text{ mH}$, $I_{AS} = 19.6 \text{ A}$, $V_{DD} = 100 \text{ V}$, $V_{GS} = 18 \text{ V}$.

$V_{(BR)DSS}$	$R_{DS(ON)} \text{ TYP}$	$I_D \text{ MAX}$
650 V	23 m Ω @ 18 V	70 A

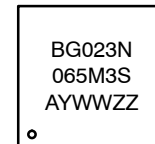


N-CHANNEL MOSFET



D2PAK-7L
CASE 418BJ

MARKING DIAGRAM



BG023N065M3S = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTBG023N065M3S	D2PAK-7L	800 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction to Case (Note 3)	$R_{\theta JC}$	0.57	°C/W
Thermal Resistance, Junction to Ambient (Note 3)	$R_{\theta JA}$	40	

3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Value	Unit
Operation Values of Gate to Source Voltage	V_{GSop}	-5...-3 +18	V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 1\text{ mA}, T_J = 25^\circ\text{C}$	650	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$\Delta V_{(BR)DSS} / \Delta T_J$	$I_D = 1\text{ mA}$, Referenced to 25°C	-	89	-	mV/°C
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 650\text{ V}, T_J = 25^\circ\text{C}$	-	-	10	μA
		$V_{DS} = 650\text{ V}, T_J = 175^\circ\text{C}$ (Note 5)	-	-	500	μA
Gate-to-Source Leakage Current	I_{GSS}	$V_{GS} = -8/+22\text{ V}, V_{DS} = 0\text{ V}$	-	-	± 1.0	μA

ON CHARACTERISTICS

Drain-to-Source On Resistance	$R_{DS(ON)}$	$V_{GS} = 18\text{ V}, I_D = 20\text{ A}, T_J = 25^\circ\text{C}$	-	23	33	m Ω
		$V_{GS} = 18\text{ V}, I_D = 20\text{ A}, T_J = 175^\circ\text{C}$ (Note 5)	-	34	-	
		$V_{GS} = 15\text{ V}, I_D = 20\text{ A}, T_J = 25^\circ\text{C}$	-	28	-	
		$V_{GS} = 15\text{ V}, I_D = 20\text{ A}, T_J = 175^\circ\text{C}$ (Note 5)	-	36	-	
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 10\text{ mA}, T_J = 25^\circ\text{C}$	2.0	2.8	4.0	V
Forward Trans-conductance	g_{FS}	$V_{DS} = 10\text{ V}, I_D = 20\text{ A}$ (Note 5)	-	14	-	S

CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	C_{ISS}	$V_{DS} = 400\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$ (Note 5)	-	1951	-	pF
Output Capacitance	C_{OSS}		-	152	-	
Reverse Transfer Capacitance	C_{RSS}		-	13	-	
Total Gate Charge	$Q_{G(TOT)}$	$V_{DD} = 400\text{ V}, I_D = 20\text{ A}, V_{GS} = -3/18\text{ V}$ (Note 5)	-	69	-	nC
Gate-to-Source Charge	Q_{GS}		-	19	-	
Gate-to-Drain Charge	Q_{GD}		-	18	-	
Gate Resistance	R_G	$f = 1\text{ MHz}$	-	4.0	-	Ω

SWITCHING CHARACTERISTICS

Turn-On Delay Time	$t_{d(ON)}$	$V_{GS} = -3/18\text{ V}, I_D = 20\text{ A}, V_{DD} = 400\text{ V},$ $R_G = 4.7\text{ }\Omega, T_J = 25^\circ\text{C}$ (Note 4, 5)	-	11	-	ns
Turn-Off Delay Time	$t_{d(OFF)}$		-	35	-	
Rise Time	t_r		-	15	-	
Fall Time	t_f		-	9.6	-	
Turn-On Switching Loss	E_{ON}		-	51	-	μJ
Turn-Off Switching Loss	E_{OFF}		-	29	-	
Total Switching Loss	E_{TOT}		-	80	-	

NTBG023N065M3S

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified) (continued)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	$t_{d(ON)}$	$V_{GS} = -3/18\text{ V}$, $I_D = 20\text{ A}$, $V_{DD} = 400\text{ V}$, $R_G = 4.7\ \Omega$, $T_J = 175^\circ\text{C}$ (Note 4, 5)	–	9.6	–	ns
Turn-Off Delay Time	$t_{d(OFF)}$		–	41	–	
Rise Time	t_r		–	14	–	
Fall Time	t_f		–	12	–	
Turn-On Switching Loss	E_{ON}		–	51	–	μJ
Turn-Off Switching Loss	E_{OFF}		–	45	–	
Total Switching Loss	E_{TOT}		–	96	–	

SOURCE-TO-DRAIN DIODE CHARACTERISTICS

Forward Diode Voltage	V_{SD}	$I_{SD} = 20\text{ A}$, $V_{GS} = -3\text{ V}$, $T_J = 25^\circ\text{C}$	–	4.5	6.0	V
		$I_{SD} = 20\text{ A}$, $V_{GS} = -3\text{ V}$, $T_J = 175^\circ\text{C}$ (Note 5)	–	4.2	–	
Reverse Recovery Time	t_{RR}	$V_{GS} = -3\text{ V}$, $I_S = 20\text{ A}$, $dI/dt = 1000\text{ A}/\mu\text{s}$, $V_{DS} = 400\text{ V}$, $T_J = 25^\circ\text{C}$ (Note 5)	–	19	–	ns
Charge time	t_a		–	11	–	
Discharge time	t_b		–	8	–	
Reverse Recovery Charge	Q_{RR}		–	97	–	nC
Reverse Recovery Energy	E_{REC}		–	8.7	–	μJ
Peak Reverse Recovery Current	I_{RRM}		–	11	–	A

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. EON/EOFF result is with body diode.

5. Defined by design, not subject to production test.

TYPICAL CHARACTERISTICS

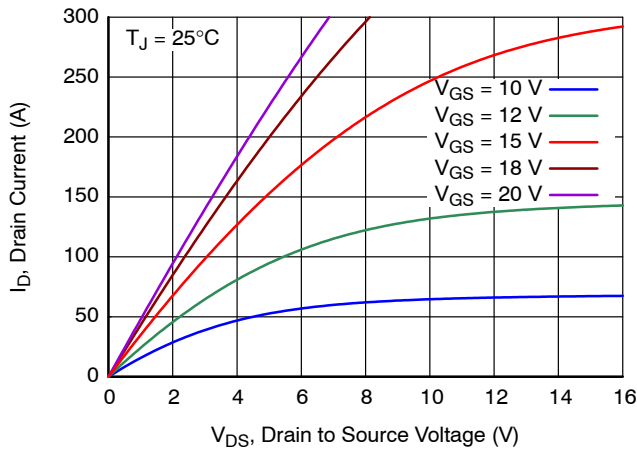


Figure 1. Output Characteristics

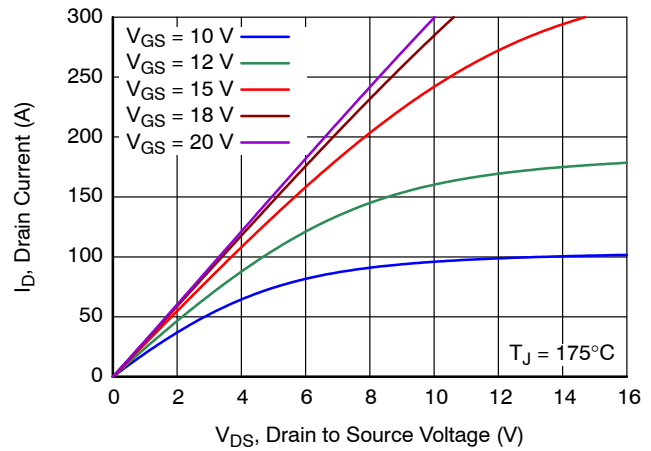


Figure 2. Output Characteristics

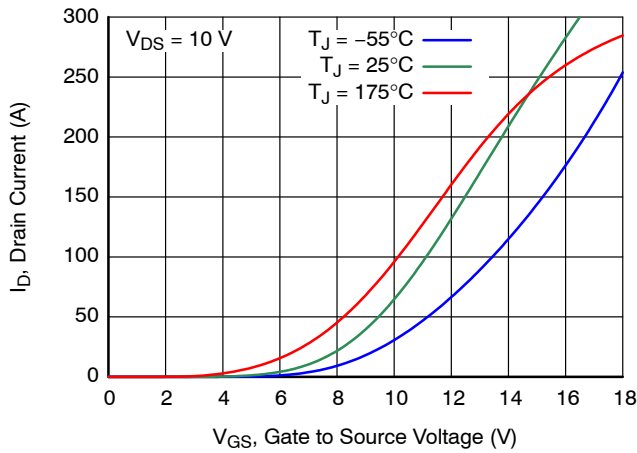


Figure 3. Transfer Characteristics

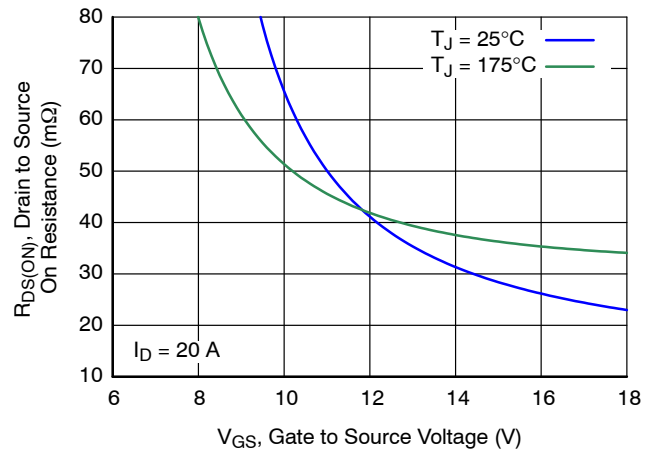


Figure 4. On-Resistance vs. Gate Voltage

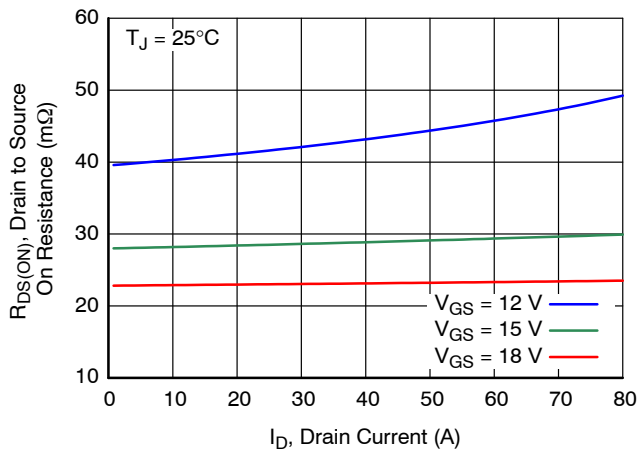


Figure 5. On-Resistance vs. Drain Current

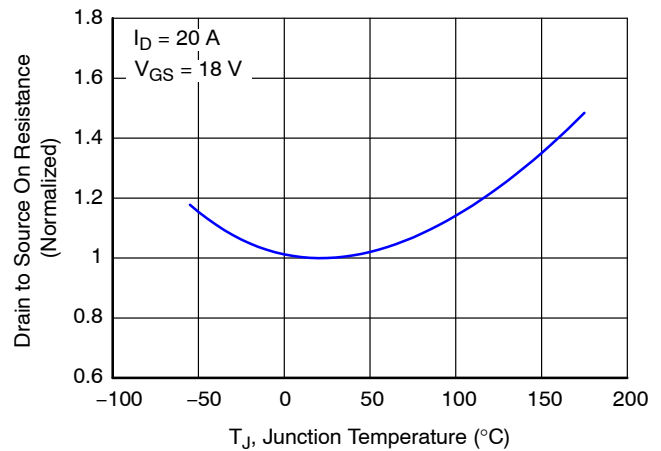


Figure 6. On-Resistance vs. Junction Temperature

TYPICAL CHARACTERISTICS

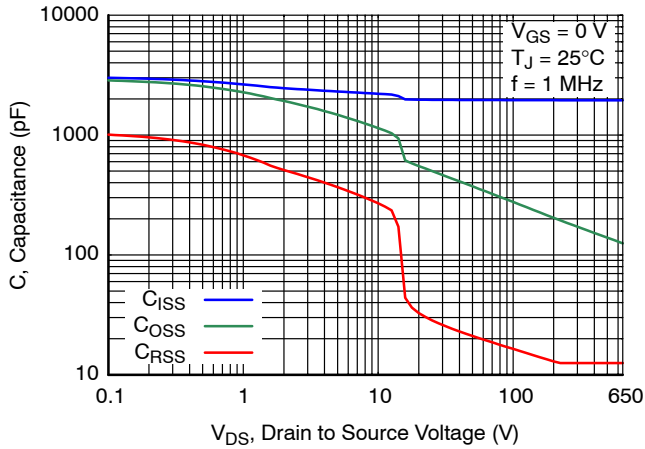


Figure 7. Capacitance Characteristics

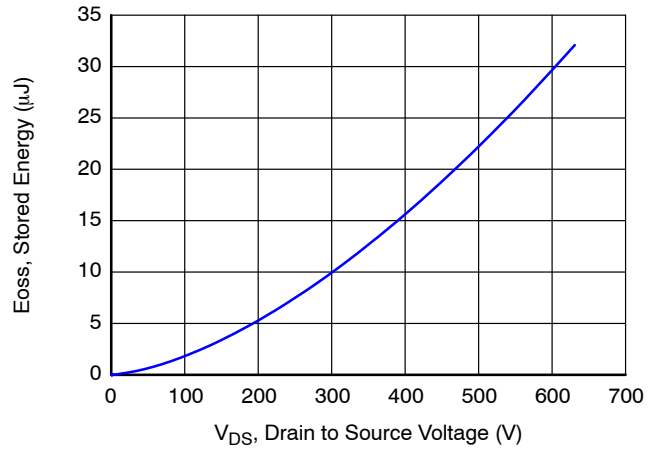


Figure 8. Stored Energy vs. Drain to Source Voltage

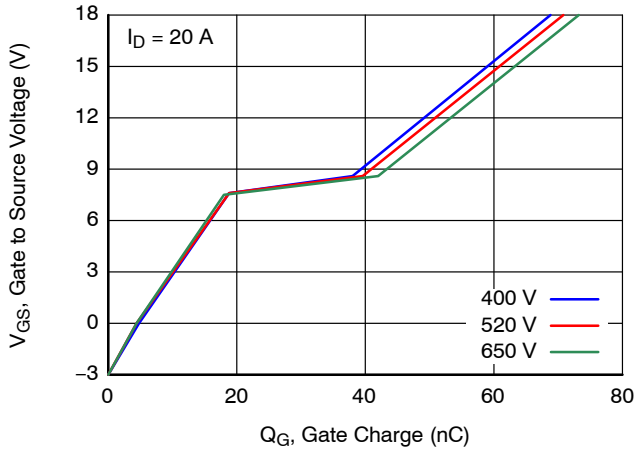


Figure 9. Gate Charge Characteristics

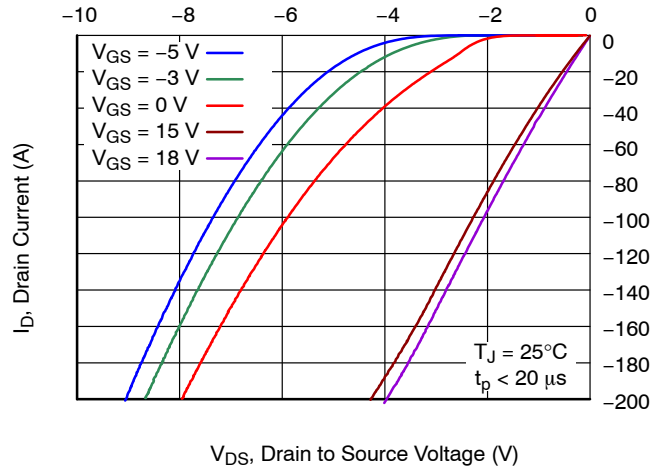


Figure 10. Reverse Conduction Characteristics

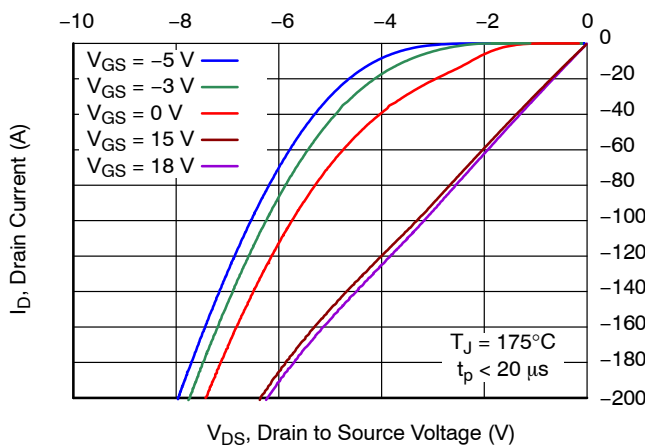


Figure 11. Reverse Conduction Characteristics

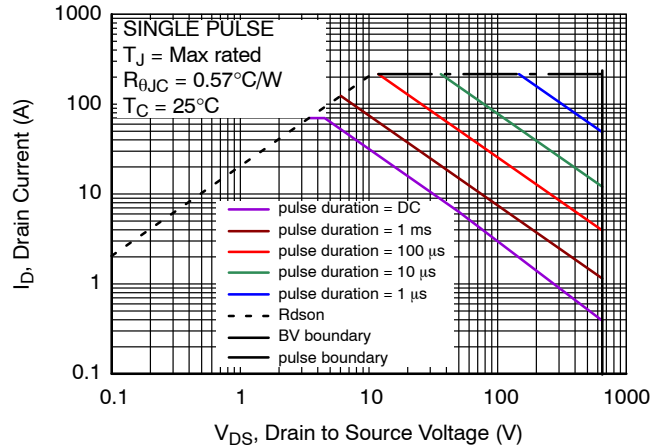


Figure 12. Safe Operating Area

TYPICAL CHARACTERISTICS

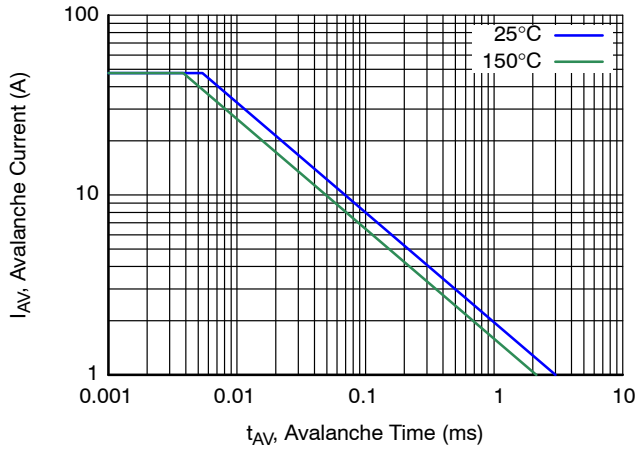


Figure 13. Avalanche Current vs. Pulse Time (UIS)

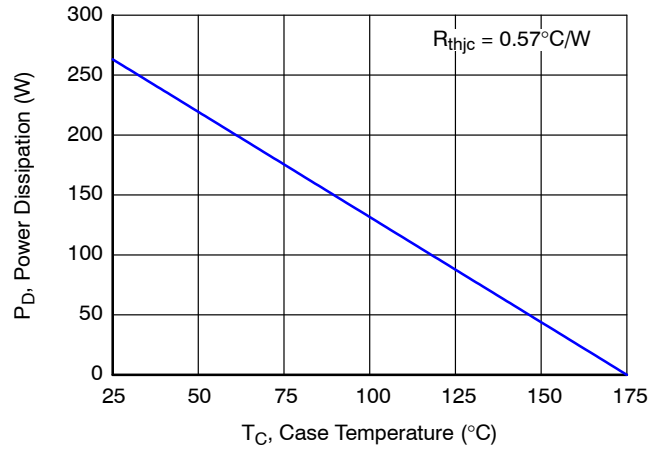


Figure 14. Maximum Power Dissipation vs. Case Temperature

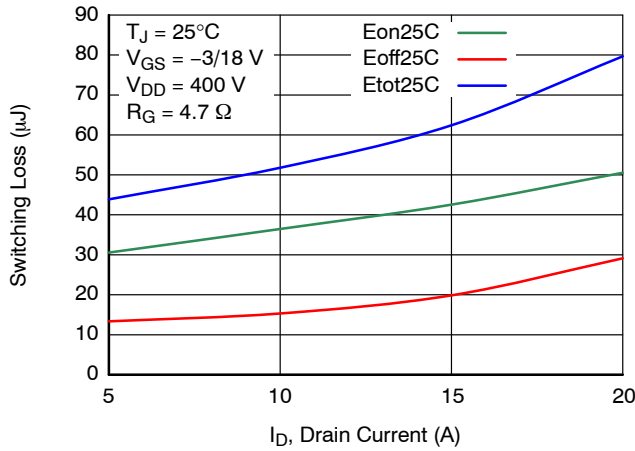


Figure 15. Inductive Switching Loss vs. Drain Current

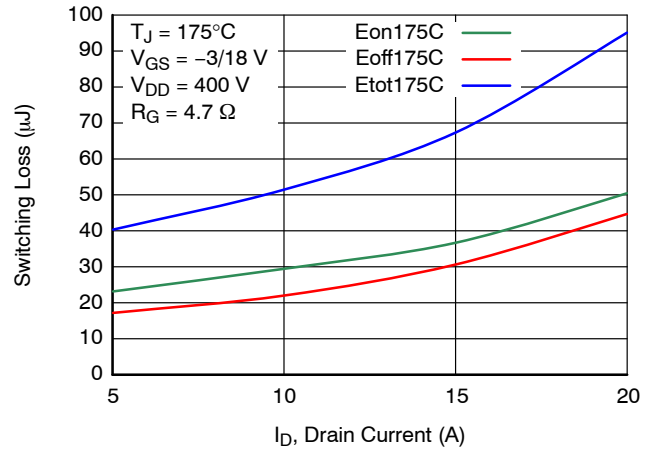


Figure 16. Inductive Switching Loss vs. Drain Current

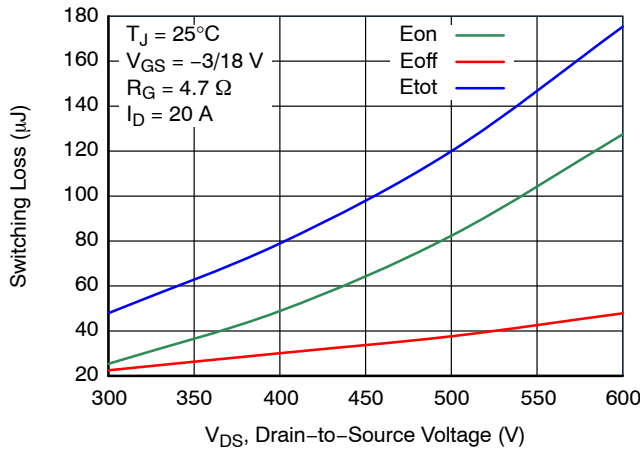


Figure 17. Inductive Switching Loss vs. Drain Voltage

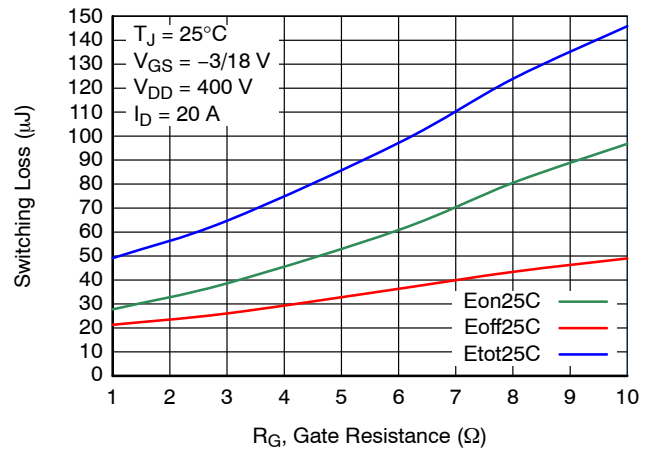


Figure 18. Inductive Switching Loss vs. Gate Resistance

TYPICAL CHARACTERISTICS

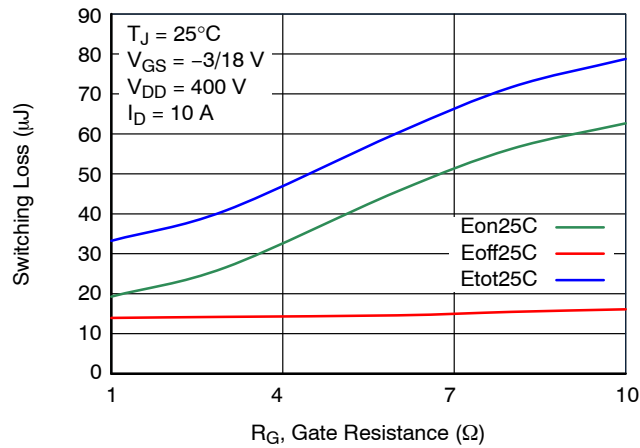


Figure 19. Inductive Switching Loss vs. Gate Resistance

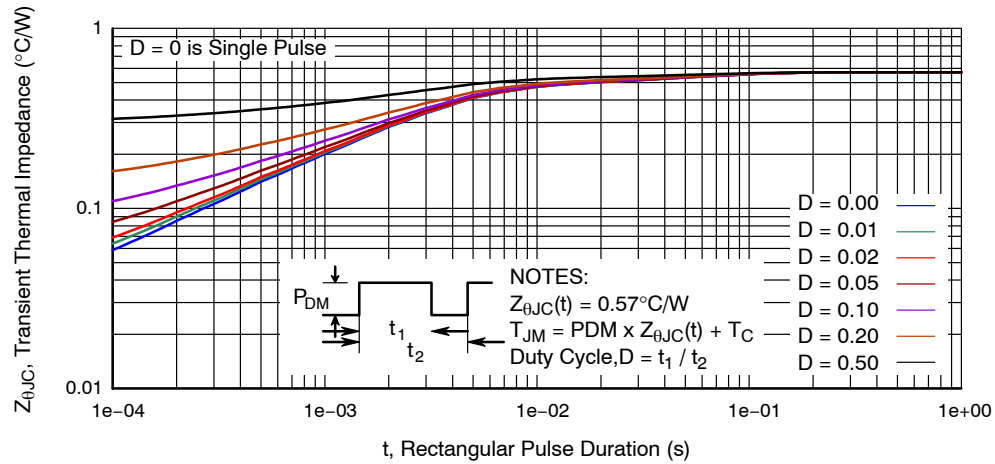
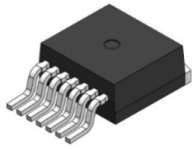
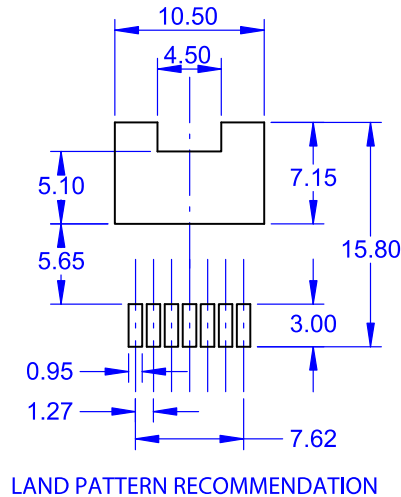
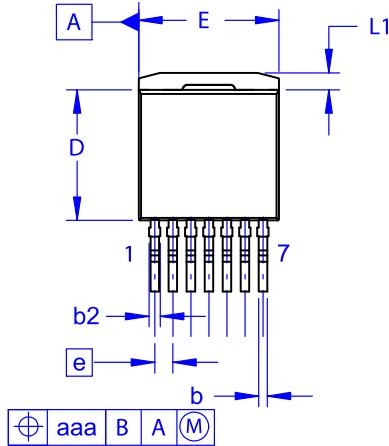


Figure 20. Thermal Response Characteristics



D²PAK7 (TO-263-7L HV)
CASE 418BJ
ISSUE B

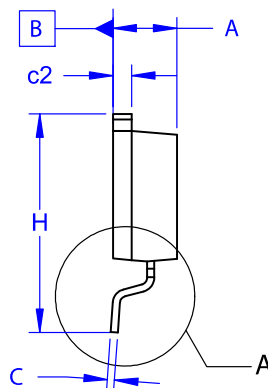
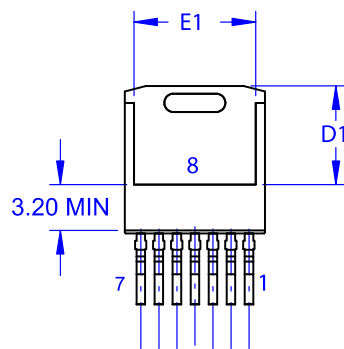
DATE 16 AUG 2019



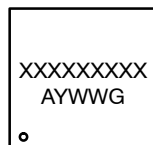
NOTES:

- A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. OUT OF JEDEC STANDARD VALUE.
- D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.
- E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

DIM	MILLIMETERS		
	MIN	NOM	MAX
A	4.30	4.50	4.70
A1	0.00	0.10	0.20
b2	0.60	0.70	0.80
b	0.51	0.60	0.70
c	0.40	0.50	0.60
c2	1.20	1.30	1.40
D	9.00	9.20	9.40
D1	6.15	6.80	7.15
E	9.70	9.90	10.20
E1	7.15	7.65	8.15
e	~	1.27	~
H	15.10	15.40	15.70
L	2.44	2.64	2.84
L1	1.00	1.20	1.40
L3	~	0.25	~
aaa	~	~	0.25

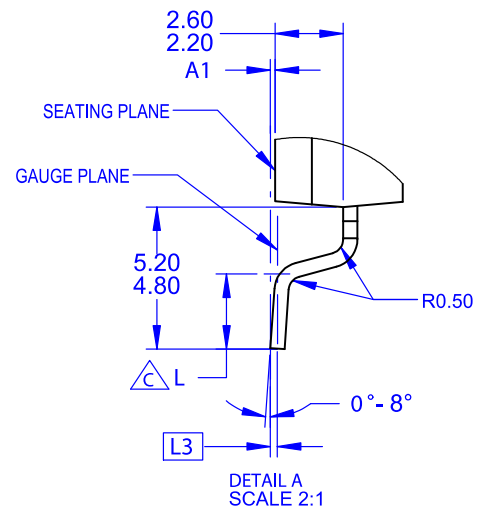


GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



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